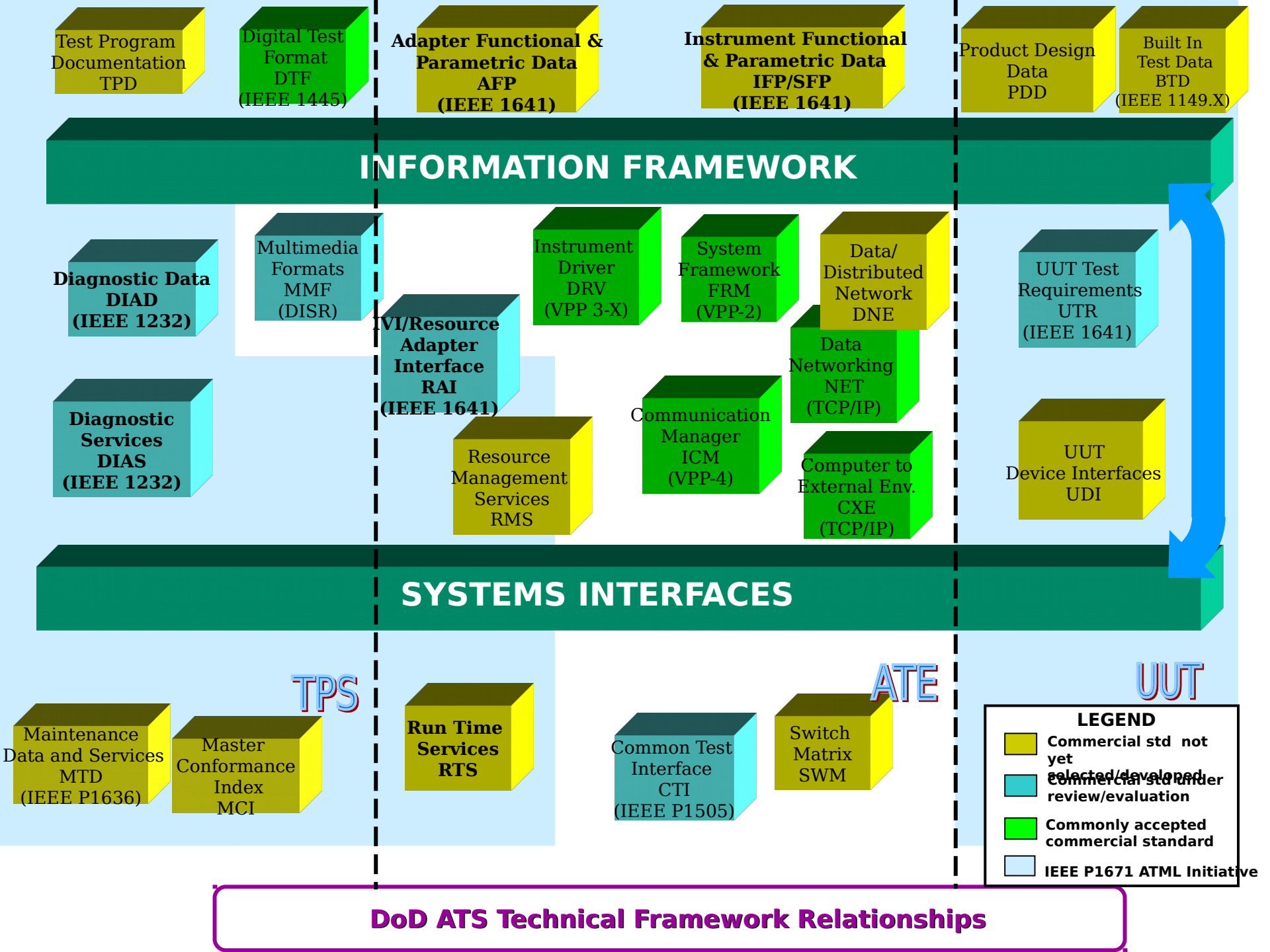
Test Program Documentation TPD
Digital Test Format DTF (IEEE 1445)
Adapter Functional & Parametric Data AFP (IEEE 1641)
Instrument Functional & Parametric Data IFP/SFP (IEEE 1641)
Product Design Data PDD
Built In Test Data BTD (IEEE 1149.X)
INFORMATION FRAMEWORK
Diagnostic Data DIAD (IEEE 1232)
Multimedia Formats MMF (DISR)
Instrument Driver DRV (VPP 3-X)
System Framework FRM (VPP-2)
Data/ Distributed Network DNE
UUT Test Requirements UTR (IEEE 1641)
VI/Resource Adapter Interface RAI (IEEE 1641)
Data Networking NET (TCP/IP)
Diagnostic Services DIAS (IEEE 1232)
Communication Manager ICM (VPP-4)
Resource Management Services RMS
Computer to External Env. CXE (TCP/IP)
UUT Device Interfaces UDI
SYSTEMS INTERFACES
TPS
ATE
UUT
Maintenance Data and Services MTD (IEEE P1636)
Master Conformance Index MCI
Run Time Services RTS
Common Test Interface CTI (IEEE P1505)
Switch Matrix SWM
LEGEND
Commercial std not yet selected/developed
Commercial std under review/evaluation
Commonly accepted commercial standard
IEEE P1671 ATML Initiative
DoD ATS Technical Framework Relationships